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| Notice of References Cited | Application/Control No. 10/655,361 | Applicant(s)/Patent Under Reexamination CHIKARA KAMI ET AL | |
| | Examiner Deborah Yee | Art Unit 1742 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------|----------------|
| | A | US-6,702,904 | 03-2004 | Kami et al. | 148/320 |
| | B | US-6,695,932 | 02-2004 | Kami et al. | 148/320 |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|--------------------|----------------|
| X | N | 359035632 | 02-1984 | Japan | Takahashi et al | 148/522 |
| X | O | 35805823 | 04-1983 | Japan | Nakai, Shuji et al | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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